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1 **Two-scale model and ocean radar Doppler spectra at moderate- and grazing angles**
Zavorotny, V.U.; Voronovich, A.G.;
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Pages:84 - 92

[Abstract]   [PDF Full-Text (304 KB)]   **IEEE JNL**

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2 **Pronunciation variation analysis based on acoustic and phonemic distance measures with application examples on Mandarin Chinese**
Ming-Yi Tsai; Lin-Shan Lee;
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[Abstract]   [PDF Full-Text (614 KB)]   **IEEE CNF**

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3 **A case study in ultrasonic cleaning damage**
Mallette, L.A.; Chen, I.; Johnson, T.W.;
Aerospace Conference, 1998. Proceedings., IEEE , Volume: 3 , 21-28 March 1
Pages:77 - 80 vol.3

[Abstract]   [PDF Full-Text (556 KB)]   **IEEE CNF**

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